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Inventor(s): **RICARDO I. FUENTES**For: **WET PROCESSING USING A FLUID MENISCUS, APPARATUS AND
METHOD**

1. Enclosed are:

17 sheets of specification, 6 sheets of claims, and 1 sheet of abstract.
 2 sheets of drawings.
 A combined Declaration & Power of Attorney

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Respectfully submitted,

Dated: Sep 28, 2000

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WET PROCESSING USING A FLUID MENISCUS,
APPARATUS AND METHOD

FIELD OF THE INVENTION

This invention relates to a method and apparatus to expose surfaces to a liquid, using at least one fluid meniscus. Such system is applicable to "wet processing" single sides of substrates, without disturbing the "backside," such as it is necessary, or would be desirable, in a variety of semiconductor and other micro-fabrication technologies. This invention is not limited to a specific area of technology or set of applications, but it is applicable to situations where exposure of surfaces to fluids is required. Examples of such are: etching, substrate thinning, electroplating, micro-structure release, device or substrate cleaning, MEMS (Micro-Electro-Mechanical Systems), optoelectronic and electronic device fabrication; to name a few.

BACKGROUND INFORMATION

Wet processing (i.e. the exposure of a surface or surfaces to a fluid or fluids) is an essential part of many technologies. In particular, semiconductor and micro-electro-mechanical systems (MEMS, also known as micro systems, among other names) technologies rely heavily on wet processes for the manufacturing of devices. Processes such as etching, resist developing, patterning, stripping, release, electroplating, and thinning are all usually performed by the exposure of surfaces to liquids; i.e. wet processing.

One of the main drawbacks of all prior art is the reliance of wet processes on immersion of the parts in a liquid, on some form of spraying, or in a combination of liquid delivery and substrate spinning, to accomplish the exposure of the surface to the liquid. These methods, and their many variants, usually expose, at least to a relevant extent, other surfaces that would be desirable to protect from the fluid. To prevent unwanted exposure of surfaces. The prior art has usually relied on the application of protective layers, or resists.

As fabrication technologies advance and higher functionality and feature densities are a major driver of systems performance and lower prices; a true single sided wet process would provide additional process flexibility and allow a higher level of integration. In particular, features or devices could be in a finished state on one side while wet processing could continue on the other side without jeopardizing its integrity by wetting it or otherwise exposing it to the fluid or its vapors, using resists, masks or other forms of protection.

There are wet processing systems that attempt to perform single sided wet processing, that is, even though the exposure takes place primarily on one side, it usually exposes the other side to relevant levels of mist or vapor. Such exposure is sufficient to either disqualify such systems for single sided processing, or merit the use of resists or other forms of protection to prevent damage to the side not being processed.

However, the present invention is capable of single-sided processing without exposing the backside of the surface in process, thus enabling a great variety of novel processes and new levels of device integration, among other things. It is clear that all applications and implications of the present invention are not all listed here, but, nevertheless, are also a part of this invention.

PURPOSES AND SUMMARY OF THE INVENTION

The invention is a novel method and an apparatus for processing a single side of an object using a fluid meniscus.

Therefore, one purpose of this invention is to provide an apparatus and a method that will allow the processing of a single side of an object using at least one fluid meniscus.

Another purpose of this invention is to utilize at least one fluid meniscus to carry out processing of objects, especially objects that are used in the electronics industry.

Therefore, in one aspect this invention comprises a fluid meniscus process, comprising the steps of:

- (a) holding at least a portion of a first surface of an object with a holding fixture, such that at least a portion of a second surface of the object is exposed;
- (b) injecting at least one liquid in a holding tank such that a fluid meniscus is formed;
- (c) contacting at least a portion of the second surface of the object with at least a portion of the fluid meniscus; and
- (d) removing the object after at least one contact with the fluid meniscus.

In another aspect this invention comprises an object having a first surface and a second surface, wherein the first surface has at least one first feature, and wherein the second surface has at least one second feature, and wherein the first feature is on the back side of the second feature, wherein the first feature is selected from a group consisting of grating, patterned features, metallic features, non-metallic features,

channel, mirror, filter, through-hole, blind hole, membrane, beam, mechanical device, optical device, optoelectronic device, CMOS, MEMS, SOI and CCD, and wherein the second feature is selected from a group consisting of grating, patterned features, metallic features, non-metallic features, channel, mirror, filter, through-hole, blind hole, membrane, beam, mechanical device, optical device, optoelectronic device, CMOS, MEMS, SOI and CCD.

In yet another aspect this invention comprises an apparatus for transferring a portion of a fluid meniscus layer on an object, comprising:

- (a) an object having a first surface and a second surface;
- 10 (b) a holding fixture to hold a portion of the first surface of the object, such that at least a portion of a second surface of the object is exposed;
- (c) at least one holding tank containing at least one fluid with a fluid meniscus;
- (d) means for transferring at least a portion of the fluid meniscus onto at least a portion of the second surface of the object; and
- 15 (e) means for removing the object after at least one contact with the fluid meniscus.

BRIEF DESCRIPTION OF THE DRAWINGS

The features of the invention believed to be novel and the elements characteristic of the invention are set forth with particularity in the appended claims. The drawings are for illustration purposes only and are not drawn to scale. Furthermore, like numbers represent like features in the drawings. The invention itself, however, both as to organization and method of operation, may best be

understood by reference to the detailed description which follows taken in conjunction with the accompanying drawings in which:

Figure 1A illustrates a preferred process and apparatus of this invention.

Figure 1B illustrates the object in contact with a fluid meniscus.

5 Figure 1C illustrates the object after making at least one contact with the fluid meniscus.

Figure 1D illustrates the object making another contact with the fluid meniscus.

Figure 2 illustrates another embodiment of this invention.

Figure 3 illustrates yet another embodiment of this invention.

Figure 4 illustrates still another embodiment of this invention.

Figure 5 illustrates yet another embodiment of this invention.

Figure 6 illustrates still another embodiment of this invention.

DETAILED DESCRIPTION OF THE INVENTION

15 Even though a large number of possible applications are conceivable, in its preferred embodiment the current invention provides a substantial improvement over

5 prior art in providing for wet processing of a single side of a substrate without adversely disturbing its backside. It is envisioned that true single sided wet processing, such as provided by the subject of this invention, enables further and faster increase of functionality and feature—or device—density per die, by easing the restrictions on using both sides of the substrate. Further, it may afford the capability to etch or thin substrates in a more environmentally safe, faster, and economic manner.

10 An example of one such application using this invention would be the integration of CMOS and MEMS devices, each type on its own side of a substrate and being run through its own processing line. This is of particular significance since this example illustrates two types of devices that would benefit from integration but which processes are mutually incompatible, therefore making their integration into the same “chip” difficult. Similar situations may apply to a variety of processes, devices, features, types or levels of integration. It is conceivable that by using a sequence of said processes a tri-dimensional device or hybrid can therefore be fabricated.

15 Another example of the advantages of true single sided wet processing is the thinning of substrates. These can be those of devices after or during processing, such as CCD, MEMS, or other optoelectronic devices; as well as blank substrates.

20 Still another advantage of this invention is the possible reduction of the cost of thin, silicon-on-insulator (SOI), and MEMS substrates, among others.

25 The high etch rates and uniformity of which the subject of this invention is capable makes it an attractive choice for the fabrication of thin substrates. A large variety of technologically relevant materials can be processed, such as, metal and non-metal composites, metal and non-metallic materials, silicon, InP (indium phosphide), ceramic and glass, among others.

The subject of this invention may also be used to clean the exposed surface via chemical agents that are delivered to it either separately, premixed, or mixed in-situ, such to accomplish the desired cleaning action. Chemicals can be made to react at, near, or en-route to the substrate to achieve the desired reaction and effect.

5 The present invention may also be used advantageously to electroplate materials onto substrates while simultaneously taking advantage of all beneficial features described in this specification. There are no intrinsic limits imposed by the subject of this invention as to the type of material to be electroplated; nor there are limitations as to other aspects of the application of the subject of this invention to electroplating. Similarly, the subject of this invention can be advantageously used to perform other electrochemical processes involving fluids and surfaces. All such uses and applications are also subjects of this invention.

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Furthermore, this invention allows for the reduced and more efficient use of chemicals used for common processes, such as etching, thinning, cleaning, developing, electroplating, among others. This is accomplished via many possible implementations of the system of this invention. One feature is its reduced use of chemicals as compared to typical immersion techniques. Another relevant implementation would be the recirculating aspect of the chemical delivery and handling. These features of the current invention, may make it an attractive alternative to current state of the art on the basis of economic and environmental advantages.

Figures 1A, 1B, 1C and 1D, illustrate an embodiment of this invention where a holding tank or a liquid module 10, has at least one fluid channel 22, and at least one fluid overflow channel 24. The fluid channel 22, contains at least one liquid 23, having at least one fluid meniscus 16. A holding fixture or a substrate module 12, securely holds at least one object 14, such as, a wafer 14, substrate 14, to name a few. The overflow channel 24, should be such that any fluid 23, that overflows as fluid 17, can be further processed, as discussed elsewhere. For the ease of understanding related motor, sensing, control subsystems; to the extent the later are required by a particular implementation, are not shown in the figures. It is evident that other combinations or modifications are possible, and are also subjects of this invention.

The substrate 14, has a first or lower surface 13, and a second or upper surface 15. The substrate 14, could be held by the substrate module 12, using a suitable vacuum, mechanical or electrostatic chuck or by other appropriate means; and scanned over the fluid meniscus 16, as many times as necessary to achieve the desired results. The speed of the scan is determined by the process requirements and results desired, and can vary from zero (i.e. substrate 14, that is exposed to the fluid 23, is at a single place and is not moving), to moving at many feet per second. Fig.1A-1D, illustrate

schematically such motion as it progresses from right (Fig. 1A) to left (Fig. 1B, 1C), and back to the right (Fig. 1D).

Similarly, the substrate 14, can be rotated at various speeds during, after, prior, in between scanning motions, or at any time as deemed necessary; depending on the process requirements and results desired. Rotational speeds can typically vary from zero (i.e. no rotation) to many thousand revolutions per second. In a preferred embodiment, the substrate module 12, may include or contain a "substrate head" 18, which contains the motors, chucks, and feedthroughs necessary to achieve the previously described motions and combinations thereof, which for the ease of understanding have not been shown here.

Also, in a preferred embodiment a gas current is employed through the gap 20, between the substrate 14, and the substrate module 12, to help prevent fluid 23, creeping or moving up onto the top surface 15. This gas current also helps minimize vapor transport onto the top surface 15, of the substrate 14. The gas used is selected to be compatible with the process and can be any gas or fluid that accomplishes such purpose. In a preferred embodiment, nitrogen or dry compressed air are used. Also, in a preferred embodiment, the gap 20, between the substrate head 12, and the substrate 14, is set such as to produce such isolation, or other desired, effects.

In a preferred embodiment, the substrate 14, moves over the meniscus 16, in such a manner as to expose successive narrow substrate area elements, or stripes, to the liquid 23. If the operation carried out involves the chemical removal of substrate material (i.e. etching), such as during a thinning operation, the geometry of the operation is analogous to that of the mechanical removal of material by a rotating planer or other similar tools. By effecting the processing in such narrow stripes, most

if not all asymmetries related to mass and thermal transport to the edges are virtually eliminated.

In a preferred embodiment, the fluid 23, used for processing is being continuously replenished into the fluid channel 22. This can be done either open or closed loop (i.e. the fluid 23, used discarded after one pass, or recycled, with or without any form of treatment, to go back into the fluid channel). The chemistry of the fluid 23, can be adjusted during such passes or not. Similarly, the temperature, or other properties, of the fluid 23, can be adjusted during such passes or not. Such choice is dependent on a variety of aspects, such as environmental, economical, process issues, throughput, and uniformity, among others. During normal operation as part of the re-circulation process or as overflow during the passage of the substrate 14, over it, the fluid 23, in the fluid channel 22, may overflow into the overflow channels 24, so that the overflowed fluid 17, can be further processed, such as, discarded, recycled, replenished by combining with a fresh batch of fluid 23, and injected back into the fluid channel 22. The fluid 23, collected herein is either accumulated, disposed off, or re-circulated, as detailed above. In a preferred embodiment vacuum is applied to the overflow channels 24, to assist in the transport of liquid 23, along its intended path; but any other arrangements, including overflow aided just by the force of gravity, vacuum-gravity combinations, chemical reaction, or electrostatic forces, or combinations thereof, are also subjects of this invention. It is also obvious that several configurations are conceivable regarding the liquid handling aspects of the system, such as different liquid removal, accumulation, pumping, confinement, and management implementations; among others. These, and all other possible, configurations and implementations are also subjects of this invention. Similarly, other geometries, arrangements, or embodiments regarding the configuration, size, shape or other characteristics of the liquid or overflow channels; including the absence, partial or total of either one of them, are also subjects of this invention. Similarly, any

configuration involving a multiplicity, or any number, of the same channels or modules is also a subject of this invention.

This invention could employ more than one liquid module 10, positioned side to side 26, as illustrated in Figure 2, in a manner that the substrate 14, is exposed to more than one liquid meniscus 16, per pass. The number of liquid modules 10, used would depend on a variety of factors, such as desired process rates, throughput, substrate geometries, among others. Many variants and combinations are conceivable and are also subjects of this invention.

Alternative embodiments of the current invention can perform a sequence of steps aimed to further and complement each other. Such furthering or enhancement of the functions of the subject of this invention, achieved either by the combination of components of this same invention, or by the addition of other mechanisms, apparatuses, devices or equipment, and the apparatuses resulting from such implementations are contemplated herein and also the subject of this invention. One such sequence may clean, etch, thin, clean, scrub, clean and rinse a substrate using the same principles described herein and are also subject of this invention. Such implementations may include, but are not limited to, sonic or ultrasonic forms of energy, mechanical scrubbing, or electromagnetic radiation as the source of the additional function.

It is also a subject of this invention where any embodiment of the above which has other forms of energy or matter attached or discharging into or around the components of the subject of this invention. Such forms may include, but are not limited to, any form of electromagnetic radiation, light, any form of acoustical energy, any form of mechanical energy, and any form of thermal energy, 41, to name a few.

Figure 3, illustrates yet another embodiment of this invention, where the object 14, has at least one protective coating 31, on its upper or second surface 15, and where the lower or the first surface 13, is in direct contact with the fluid 23, and the fluid meniscus 16.

Figure 4, illustrates still another embodiment of this invention, where the lower or the first surface 13, of the object 14, is in direct contact with the fluid 23, and the fluid meniscus 16, within the holding tank 10, and wherein the holding fixture or substrate head 18, and/or the holding tank 10, has at least one energy source 41. The energy source 41, could be selected from a group comprising electromagnetic radiation, light, acoustical energy, mechanical energy, thermal energy, to name a few. For example, the energy source 41, could be a beam of light 41, that is shined through the fluid 23, towards the fluid meniscus 16, and the first or lower surface 13, of the object 14, to perform, for example, a photo lithographic operation, a photochemical operation, a photo-electro-plating operation, selective plating, selective etching, to name a few.

Figure 5, illustrates yet another embodiment of this invention, where the object 14, has a first surface 13, 15, and a second surface 13, 15, , wherein the first surface 13, 15, has at least one first feature 53, 55, of a first type 53, 55, and wherein the second surface 13, 15, has at least one second feature 53, 55, of a second type 53, 55, and wherein the first feature 53, 55, of the first type 53, 55, is different than the second feature 53, 55, of the second type 53, 55. For example, the first feature 53, 55, could be selected from a group of active features comprising CMOS, MEMS, SOI or CCD (couple charged device), to name a few, or passive features, for example, grating, metal or non-metal lines and/or vias. Similarly, the second feature 53, 55, could be selected from a group of active features comprising CMOS, MEMS, CCD or SOI, to name a few, or passive features, for example, grating.

Figure 6, illustrates still another embodiment of this invention, where the object 14, has a portion of the first surface 13, covered with at least one protective layer 61, while leaving a portion of the first surface 13, exposed for processing, such as, to allow the exposed surface 13, to make direct contact with the fluid meniscus 16, of the fluid 23. The area under the protective layer 61, could be a virgin surface area 13, or a previously processed area 13, or an area 13, having one or more features 53, 55, that are being protected by the layer 61. Such a protective layer 61, could be used in an electronic process, such as, using a resist layer 61, to protect a portion of the surface 13, of a wafer 14. The protective layer 61, could be an organic layer 61, or an inorganic layer 61.

It should be understood that there are a number of ways to hold the object 14, for example, the object 14, could be held to the holding fixture 12, by a method selected from a group comprising mechanical means, electrostatic means, fluidic means, using for example, Bernoulli's principles, magnetic means, electromagnetic means, or other non-contact methods, to name a few.

The applicant has used the term "single-sided" or "single-sided processing" to clarify that while one surface is being processed or is in contact with the fluid meniscus 16, of the fluid 23, the other side or the second surface or the backside of the object 14, is not disturbed during the processing the first side.

This invention allows that a structure or device can be built on both sides of the object, such as, a wafer or substrate, which could not be built otherwise by conventional means. For example, one could use this invention to build at least one CMOS device on one side and another different device on the same side, or another CMOS or another different device on the other or backside. The use of the "real

estate" on both sides is made possible by the use of the invention's "true single sided" processing capability.

It should be understood that the device(s) on either side of the wafer or the object do not have to be different. One could have CMOS on one side and CMOS on the other, or one could have any combination of active and/or passive devices, such as, CMOS and MEMS, gratings and MEMS, gratings and optics, photo-electronic and gratings, to name a few, on each side respectively. One can also see that this invention enables the use of both sides of an object, such as, a wafer, in a simple, efficient and cost effective manner. However, one could also use this invention to make other features/structures, such as, for example, channel, mirror, filter, hole, membrane, beam, optoelectronic and mechanical devices, or other similar features/structures.

Furthermore, the object could be made of a variety of materials, such as, for example, a group IV element (e.g. Si), group III and V compounds (e.g. InP), group II and VI compounds (e.g. CdSe, HgTe), or other binaries (e.g. SiN) and ternaries between these systems (e.g. AlGaAs).

For most applications the holding fixture 12, 18, would move the object 14, into contact with the fluid meniscus 16. However, in some cases the holding tank 10, containing the fluid 23, may be made to move so that the fluid meniscus 16, comes into contact with the surface of the object 14. For some applications one could move the holding fixture 12, 18, and also the holding tank 10, at the same time, and at the same or different speeds.

Although many embodiments, variations and combinations are conceivable, and also subjects of this invention; some such relevant embodiments and variations are listed below:

This invention, its variants, and its alternative embodiments, independently of its applications or processes it may be applied to any similar apparatus and/or process.

This invention could utilize any fluid 23, as long as the fluid 23, forms at least one fluid meniscus 16.

5 This invention can be used with any geometry of surface, surfaces, or substrates 14. This invention can be used with any topography of surface, surfaces, or substrates 14. Similarly, this invention can be used with any substrate material or substance.

This invention as discussed elsewhere can be used to perform any other processes, in addition to those mentioned in this specification.

This invention allows it to be used in any other configurations, in addition to those being mentioned in this specification.

This invention can be implemented along with any other form of energy source, in addition to those being mentioned in this specification.

15 This invention can be used inverted, rotated or mirrored about any of its axis.

This invention can be used with a different number of liquid modules 10, other than the ones described in the specification.

This invention can be used with a different number of fluids 23, or overflow channels 24, than the ones described in this specification.

This invention can be modified to embody different arrangements, variations, or geometries of its fluids 23, and the overflow channels 24, in addition to described in the specification.

5 This invention also allows the using of different combinations of moving and stationary components, such as, a stationary substrate 14, and a moving liquid module 10, or any other combinations or permutations thereof.

This invention also allows the use of components that perform any form or motion, including, but no limited to, rotation, translation, or oscillation of its components relative to each other or to an external frame of reference.

This invention can utilize components that perform any function other than those described in this specification, including, but no limited to, components that perform heating, scrubbing, bombardment with any type of particles, supercritical gas cleaning, ultrasonic cleaning or excitation, laser exposure or exposure to any form of radiation, to name a few.

This invention can be used, or having any number of its components, in an inverted fashion (i.e. upside down).

This invention can be used, or having any number of its components, at an angle from the horizontal.

20 This invention could allow the removal of fluid or fluids 23, which could be accomplished via other means or arrangements in addition to those described in this specification, such as, but not limited to, suction, gravity, chemical reaction, moving gas or fluid, displacement, mechanical, electromagnetic, to name a few.

This invention could be used with the delivery of fluid or fluids 23, which could be accomplished via different means or arrangements in addition to those described in this specification, such as, suction.

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While the present invention has been particularly described, in conjunction with a specific preferred embodiment, it is evident that many alternatives, modifications and variations will be apparent to those skilled in the art in light of the foregoing description. It is therefore contemplated that the appended claims will embrace any such alternatives, modifications and variations as falling within the true scope and spirit of the present invention.

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WHAT IS CLAIMED IS:

1. A fluid meniscus process, comprising the steps of:
 - (a) holding at least a portion of a first surface of an object with a holding fixture, such that at least a portion of a second surface of the object is exposed;
 - (b) injecting at least one liquid in a holding tank such that a fluid meniscus is formed;
 - (c) contacting at least a portion of the second surface of the object with at least a portion of the fluid meniscus; and
 - (d) removing the object after at least one contact with the fluid meniscus.
2. The fluid meniscus process of claim 1, wherein the object is selected from a group consisting of semiconductor wafer, substrate, metal and non-metal composites, metal and non-metallic material, silicon, indium phosphide, ceramic, glass, group IV element, group III-V compound, group II-VI compound, and binaries and ternaries thereof.
3. The fluid meniscus process of claim 1, wherein the object is held to the holding fixture using a method selected from a group consisting of mechanical means, vacuum means, electrostatic means, fluidic means, magnetic means and electromagnetic means.
4. The fluid meniscus process of claim 1, wherein the fluid is selected from a group consisting of an etching fluid, a plating fluid, a solvent, a photo resist, a developer and a stripper.

5. The fluid meniscus process of claim 1, wherein the fluid in the holding tank is re-circulated, agitated, heated and replenished.

6. The fluid meniscus process of claim 1, wherein the object has at least one coating of at least one material, and wherein the coating is selected from a group consisting of metal, organic material, inorganic material, insulator and resist.

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7. The fluid meniscus process of claim 1, wherein the holding tank has at least one channel to hold the fluid.

8. The fluid meniscus process of claim 1, wherein the holding tank has at least one overflow channel.

9. The fluid meniscus process of claim 1, wherein the fluid is injected onto the holding tank using at least one pump.

10. The fluid meniscus process of claim 1, wherein the fluid etches at least a portion of the second surface of the object, and wherein the object is selected from a group consisting of semiconductor wafer, substrate, metal and non-metal composites, metal and non-metallic material, silicon, indium phosphide, ceramic, glass, group IV element, group III-V compound, group II-VI compound, and binaries and ternaries thereof.

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11. The fluid meniscus process of claim 1, wherein the fluid meniscus is formed above the edges of the holding tank.

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12. The fluid meniscus process of claim 1, wherein the fluid meniscus is used to perform a function selected from a group consisting of etching, thinning, electroplating, micro-structure release, cleaning, electronic device fabrication, electrochemical processing, photochemical processing, photo-electro plating, optoelectronic processing, patterning, resist application, developing, plating, coating and stripping.

13. The fluid meniscus process of claim 1, wherein at least a portion of the surface in contact with the holding fixture has at least one layer of protective material.

14. The fluid meniscus process of claim 1, wherein at least a portion of the surface in contact with the holding fixture has at least one layer of protective material, and wherein the protective material is selected from a group consisting of photosensitive material and photo resist material.

15. The fluid meniscus process of claim 1, wherein at least a portion of the surface in contact with the fluid meniscus has at least one layer of protective material.

16. The fluid meniscus process of claim 1, wherein at least a portion of the surface in contact with the fluid meniscus has at least one layer of protective material, and wherein the protective material is selected from a group consisting of photosensitive material and photo resist material.

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17. The fluid meniscus process of claim 1, wherein the object is moved in a manner selected from a group consisting of rotation, oscillation and linear translation.

18. The fluid meniscus process of claim 1, wherein at least one gas current is supplied to the object.

19. The fluid meniscus process of claim 1, wherein at least one gas current is supplied to the object, and wherein the gas is selected from a group consisting of nitrogen and dry compressed air.

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20. The fluid meniscus process of claim 1, wherein the object is subjected to an energy source selected from a group consisting of electromagnetic radiation, light, acoustical energy, mechanical energy, and thermal energy.

21. The fluid meniscus process of claim 1, wherein the object is subjected to an energy source selected from a group consisting of electromagnetic radiation, light, acoustical energy, mechanical energy, and thermal energy, and wherein the energy source is secured to the holding fixture.

22. The fluid meniscus process of claim 1, wherein the object is subjected to an energy source selected from a group consisting of electromagnetic radiation, light, acoustical energy, mechanical energy, and thermal energy, and wherein the energy source is secured to the holding tank.

23. The fluid meniscus process of claim 1, wherein after step (c) or (d) the object is repositioned so that at least a portion of the first surface of the object contacts at least a portion of the fluid meniscus.

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24. The fluid meniscus process of claim 1, wherein the first surface is on the backside of the second surface.

25. The fluid meniscus process of claim 1, wherein the first surface is adjacent the second surface.

26. The fluid meniscus process of claim 1, wherein the holding fixture moves the object into contact with the fluid meniscus.

5 27. The fluid meniscus process of claim 1, wherein the holding tank moves the fluid meniscus into contact with the object.

28. An object having a first surface and a second surface, wherein the first surface has at least one first feature, and wherein the second surface has at least one second feature, and wherein the first feature is on the back side of the second feature, wherein the first feature is selected from a group consisting of grating, patterned features, metallic features, non-metallic features, channel, mirror, filter, through-hole, blind hole, membrane, beam, mechanical device, optical device, optoelectronic device, CMOS, MEMS, SOI and CCD, and wherein the second feature is selected from a group consisting of grating, patterned features, metallic features, non-metallic features, channel, mirror, filter, through-hole, blind hole, membrane, beam, mechanical device, optical device, optoelectronic device, CMOS, MEMS, SOI and CCD.

29. The object of claim 28, wherein the object is selected from a group consisting of semiconductor wafer, substrate, metal and non-metal composites, metal and non-metallic material, silicon, indium phosphide, ceramic, glass, group IV element, group III-V compound, group II-VI compound, and binaries and ternaries thereof.

30. An apparatus for transferring a portion of a fluid meniscus layer on an object, comprising:

- (a) an object having a first surface and a second surface;
- (b) a holding fixture to hold a portion of the first surface of the object, such that at least a portion of a second surface of the object is exposed;
- (c) at least one holding tank containing at least one fluid with a fluid meniscus;
- (d) means for transferring at least a portion of the fluid meniscus onto at least a portion of the second surface of the object; and
- (e) means for removing the object after at least one contact with the fluid meniscus.

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WET PROCESSING USING A FLUID MENISCUS,
APPARATUS AND METHOD

ABSTRACT OF THE DISCLOSURE

A wet processing apparatus and method that takes advantage of a fluid meniscus to process at least a portion of a surface of an object. After one surface of the object has been processed another side or surface of the object can be similarly processed. This processing can be coating, etching, plating, to name a few. An application of the apparatus and method is in the semiconductor processing industry, especially, the processing of wafers and substrates. The method and apparatus also allows the processing of multiple surfaces of an electronic component.

FIG. 1A

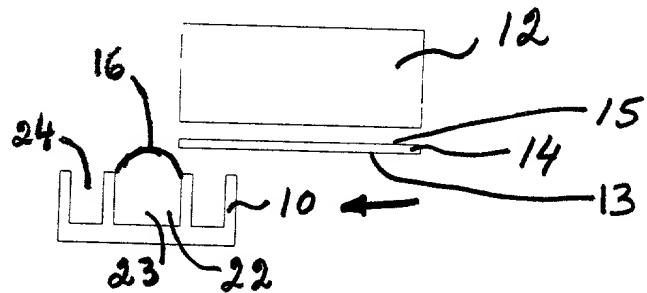


FIG. 1B

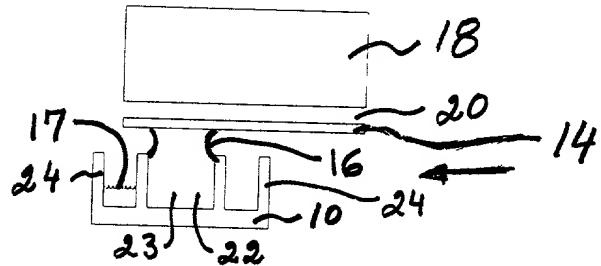


FIG. 1C

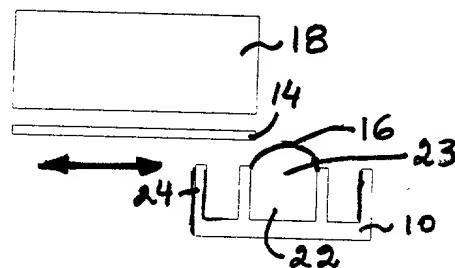


FIG. 1D

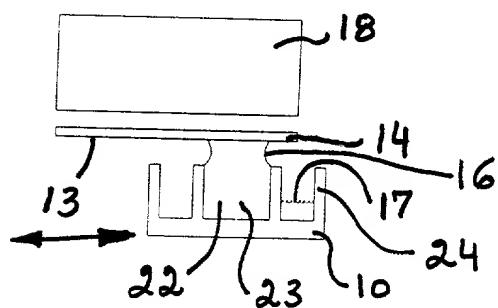


FIG. 2

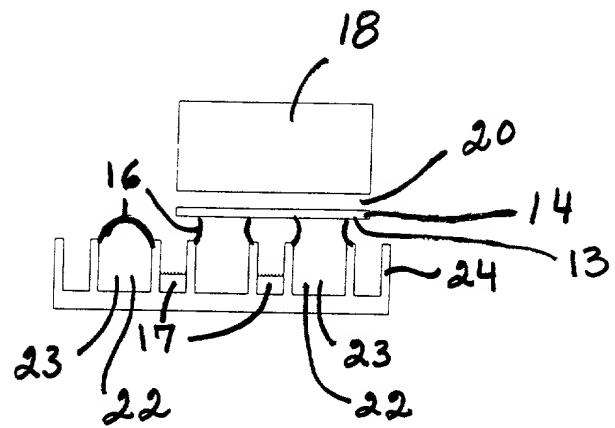


FIG. 3

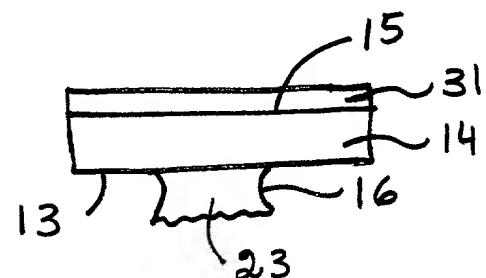


FIG. 4

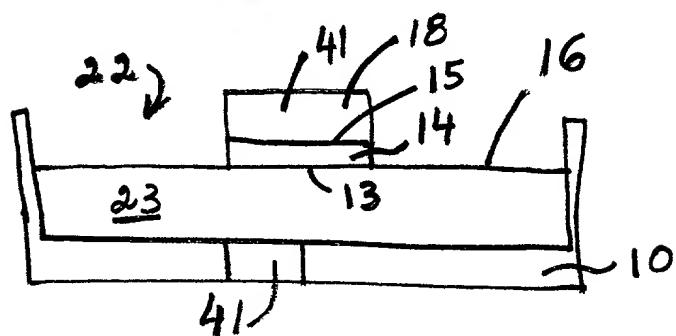


FIG. 5

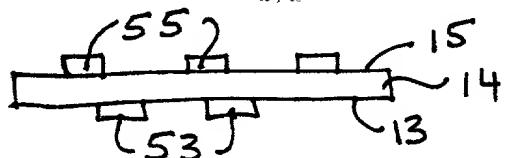
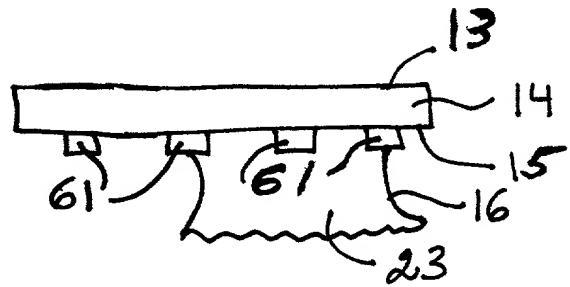


FIG. 6



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[11828/1]

DECLARATION AND POWER OF ATTORNEY

As a below named inventor, I hereby declare that:

My residence, post office address and citizenship are as stated below next to my name.

I believe I am the original, first, and sole inventor of the subject matter which is claimed and for which a patent is sought on the invention entitled **WET PROCESSING USING A FLUID MENISCUS, APPARATUS AND METHOD**, the specification of which was filed in the United States Patent and Trademark Office on September 28, 2000, as U.S. Serial No.

I hereby state that I have reviewed and understand the contents of the above-identified specification, including the claims.

* I acknowledge the duty to disclose information which is material to the examination of this application in accordance with Title 37, Code of Federal Regulations, § 1.56(a).

I hereby claim priority benefits under Title 35, United States Code, § 119 of any United States provisional application(s) for patent listed below and have also identified below any United States provisional application(s) for patent having a filing date before that of the application on which priority is claimed:

PRIOR UNITED STATES APPLICATION(S)

Number	Country filed	Day/month/year	Priority Claimed Under 35 USC § 119
60/156,582	USA	29 September 1999 (29/09/99)	Yes

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And I hereby appoint Gerard A. Messina (Reg. No. 35,952) and Aziz M. Ahsan (Reg. No. 32,100) my attorneys with full power of substitution and revocation, to prosecute this application and to transact all business in the Patent and Trademark Office connected therewith.

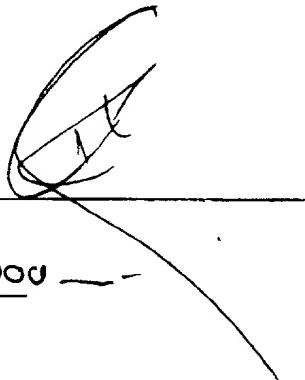
Please address all communications regarding this application to:

KENYON & KENYON
One Broadway
New York, New York 10004

Please direct all telephone calls to Aziz M. Ahsan (212) 908-6062.

I hereby declare that all statements made herein of my own knowledge are true and that all statements made on information and belief are believed to be true; and further that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under Section 1001 of Title 18 of the United States Code and that such willful and false statements may jeopardize the validity of the application or any patent issued thereon.

Inventor: Ricardo I. Fuentes

Inventor's Signature: 

Date: Sep. 28, 2000

Residence: 64 Stormville Road
Hopewell Junction, NY 12533

Citizenship: Mexico

Post Office Address: Same as above.